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Kennaugh, E.;

Antennas and Propagation, IEEE Transactions on [legacy, pre - 1988], Volume:

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[PDF Full-Text (488 KB)] [Abstract] **IEEE JNL**

2 Register transfer level power optimization with emphasis on glitch analysis and reduction

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3 On the functional validity of the worm-killing worm

Hyogen Kim; Inhye Kang;

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[PDF Full-Text (513 KB)] [Abstract] **IEEE CNF** feee home I search feee I shop I web account I contact feee



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1 BiCMOS dynamic Manchester carry look ahead circuit for high speed arithmetic unit VLSI

Kuo, J.B.; Liao, H.J.; Chen, H.P.;

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Ruiz, G.A.;

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